

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

Application Number : (unassigned)
Applicant : YOO, Woong-Tuk
Filed : December 6, 2005
Tech Cntr/AU : (unassigned)
Examiner : (unassigned)
Entitled : THE PUPIL DETECTION METHOD AND SHAPE
DESCRIPTOR EXTRACTION METHOD FOR A IRIS RECOGNITION,
IRIS FEATURE EXTRACTION APPARATUS AND METHOD, AND
IRIS RECOGNITION SYSTEM AND METHOD USING ITS
Attorney Reference : 123037-05154902
Customer Number : 43569

MAIL STOP PCT

Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. §1.97

Sir:

Pursuant to 37 CFR §1.97 and 1.56, the attention of the U.S. Patent and Trademark Office is hereby directed to the following disclosures made herein, which include:

REFERENCES AND RELEVANCY

- ☒ Applicant(s) wish(es) to make of record the documents listed on the attached Form PTO-1449. Copies of the listed documents are attached, where required, as are any readily available full or partial English translations of any non-English language documents.
- ☐ Applicant(s) wish(es) to make of record the documents listed on the attached Form PTO-1449. The references cited herein were cited for consideration in the parent application, and, pursuant to 37 CFR 1.98(d), copies of the cited references can be found in the file of the parent application (U.S. Serial No. , filed).
- ☒ Applicant(s) wish(es) to make of record the documents listed on the attached Form PTO-1449. The references cited herein were cited in the International Search Report issued for the corresponding International application, and copies of the International Search Report and the cited references are attached for the Examiner's consideration.
- ☐ Applicant(s) wish(es) to make of record the documents listed on the attached Form PTO-1449. The references cited herein were cited in a communication from a foreign or international patent office in a counterpart foreign or international application(s), and copies of both the relevant communication and the cited references, where required, are attached for the Examiner's consideration.

IAP8 Rec'd PCT/PTO 06 DEC 2005

The Examiner is further respectfully requested to return of a copy of the enclosed Form PTO-1449 with the Examiner's initials in the left column.

The examination and allowance of this Application is respectfully requested.

Respectfully Submitted,

MAYER BROWN ROWE & MAW LLP

By: 

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Date: December 6, 2005

Attachment(s): PTO Form 1449
International Search Report
Cited References

U.S. Department of Commerce
U.S. Patent & Trademark Office

LAPR Rec'd PCT/140 00 DEC 2005

INFORMATION DISCLOSURE STATEMENT
BY APPLICANT

Attorney Reference: 123037-05154902

Applicant: Woong-Tuk YOO

Application Serial No.: (unassigned)

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Examiner: unassigned

Group Art Unit: unassigned

U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/DD/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
AR	5,891,132	04/06/1999	Hohla	A61F	9/00	05/30/1996
BR	6,325,765	12/04/2001	Hay et al.	A61B	5/00	04/14/2000
CR						
DR						
ER						
FR						

FOREIGN PATENT DOCUMENTS

	Document Number	Date MM/DD/YYYY	Country	Translation Readily Available		English Abstract	
				Enclosed	No	Enclosed	No
GR	1020020060271	07/18/2002	Republic of Korea		X	X	
HR	1020020011529	02/09/2002	Republic of Korea		X	X	
IR							
JR							
KR							
LR							
MR							

OTHER (including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

NR	International Search Report dated 19, January 2005 for PCT/KR2004/002285
OR	
RR	
OR	
RR	
SR	

Examiner /Michael Vanchy Jr/

Date Considered: 03/21/2011

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.